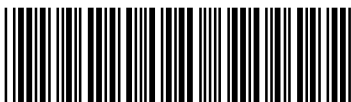


Search Notes

Application/Control No.

10/593,724

Examiner

Jinhee J. Lee

Applicant(s)/Patent under
Reexamination

YAJIMA ET AL.

Art Unit

2174

SEARCHED

Class	Subclass	Date	Examiner
715	712	3/14/2008	LEE

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East search attached	3/14/2008	LEE